

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10538825	YE, CHUN
Examiner Chapel, Derek S	Art Unit	
		2872

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Fayed Assaf about the case.	12/8/2006	DSC
EAST Update Search, see attached	12/8/2006	DSC
NPL Search, see attached	12/10/2006	DSC
Consulted with Arnel Lavarias about the allowability of the case	12/11/2006	DSC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference Search, see .clm. search attached	12/8/2006	DSC